## Notice of References Cited

Application/Control No. 09/542,873

Applicant(s)/Patent Under Reexamination THIEM ET AL.

Examiner

P. Kathryn Bex

Art Unit 1743

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.